

SILICON TRANSISTORS

2SD1615, 2SD1615A

NPN SILICON EPITAXIAL TRANSISTORS POWER MINI MOLD

DESCRIPTION

2SD1615, 1615A are designed for audio frequency power amplifier and switching application, especially in Hybrid Integrated Circuits.

FEATURES

- · World Standard Miniature Package
- Low Vce (sat) Vce(sat) = 0.15 V
- · Complement to 2SB1115, 2SD1115A

ABSOLUTE MAXIMUM RATINGS

Maximum Voltages and Currents ($T_A = 25$	°C)	2SD1615	2SD1615A	
Collector to Base Voltage	Vсво	60	120	V
Collector to Emitter Voltage	V_{CEO}	50	60	V
Emitter to Base Voltage	V_{EBO}	ϵ	, 5	Α
Collector Current (DC)	lc	1		Α
Collector Current (Pulse)*	Ic	2	2	Α
Maximum Power Dissipation				
Total Power Dissipation				
at 25 °C Ambient Temperature**	Рт	2.	.0	W
Maximum Temperatures				
Junction Temperature	Tj	15	50	,C
Storage Temperature Range	Tstg	-55 to	+150	°С
,				

^{*} PW \leq 10 ms, Duty Cycle \leq 50 %

PACKAGE DIMENSIONS in millimeters 4.5±0.1 1.6±0.2 1.5±0.1 1.5±0.1 1.5±0.1 1.5±0.4 1.5±0.47 1.5±0.47 1.5±0.47 1.5±0.47 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS (TA = 25 °C)

CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNIT		TEST CONDITIONS
Collector Cutoff Current	Ісво			100	nA	2SD1615	Vcb = 60 V, IE = 0
				100	nA	2SD1615A	V _{CB} = 120 V, I _E = 0
Emitter Cutoff Current	Ієво			100	nA	V _{EB} = 6.0 V, I _C = 0	
DC Current Gain	h _{FE1} ***	135	290	600		2SC1615	Vce = 2.0 V, Ic = 100 mA
		135		400		2SD1615A	
DC Current Gain	hFE2***	81	270			Vce = 2.0 V, Ic = 1.0 A	
Collector Saturation Voltage	VcE(sat)***		0.15	0.3	V	Ic = 1.0 A, I _B = 50 mA	
Base Saturation Voltage	V _{BE(sat)} ***		0.9	1.2	V	Ic = 1.0 A, IB = 50 mA	
Base to Emitter Voltage	VBE***	600		700	mV	Vce = 2.0 V, Ic = 50 mA	
Gain Bandwidth Product	f⊤	80	160		MHz	Vce = 2.0 V, Ie = -100 mA	
Output Capacitance	Cob		19		pF	$V_{CB} = 10 \text{ V}, I_E = 0, f = 1.0 \text{ MHz}$	

^{***} Pulsed: PW \leq 350 μ s, Duty Cycle \leq 2 %

hfe Classification

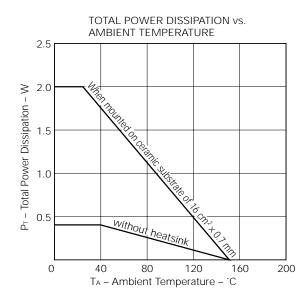
MARKING	2SD1615	GM	GL	GK
	2SD1615A	GQ	GP	
h	E	135 to 270	200 to 400	300 to 600

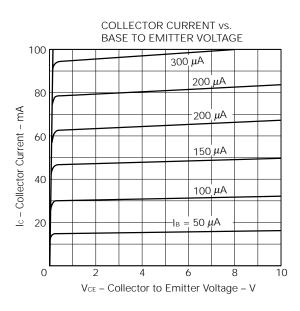
Printed in Japan

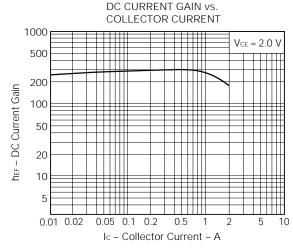
^{**} When mounted on ceramic substrate of 16 cm $^2 \times 0.7$ mm

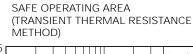


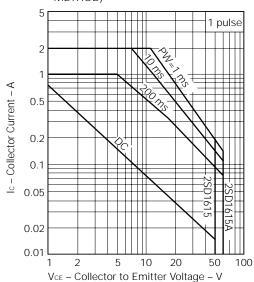
TYPICAL CHARACTERISTICS (T_A = 25 °C)



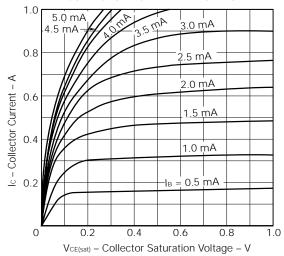




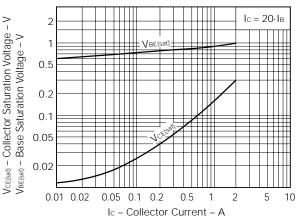


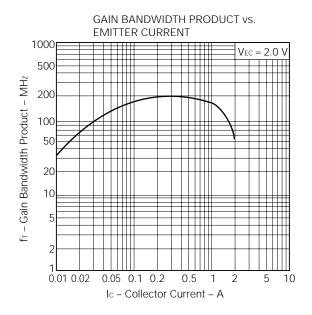


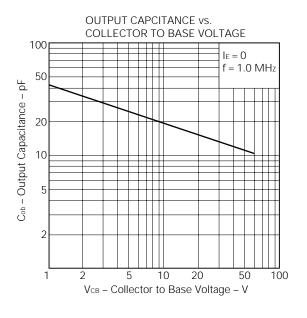
COLLECTOR CURRENT vs. COLLECTOR TO EMITTER VOLTAGE

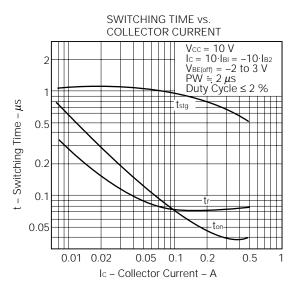


COLLECTOR AND BASE SATURATION VOLTAGE vs. COLLECTOR CURRENT









REFERENCE

Document Name	Document No.		
NEC semiconductor device reliability/quality control system.	TEI-1202		
Quality grade on NEC semiconductor devices.	IEI-1209		
Semiconductor device mounting technology manual.	IEI-1207		
Semiconductor device package manual.	IEI-1213		
Guide to quality assurance for semiconductor devices.	MEI-1202		
Semiconductor selection guide.	MF-1134		

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Anti-radioactive design is not implemented in this product.

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